

SANYO Semiconductors

DATA SHEET

An ON Semiconductor Company

STK984-091A-E — Thick-Film Hybrid IC 3-phase Blush-less DC Motor Driver IC

Overview

The STK984-091A-E is a hybrid IC designed to be used in Blush-less DC Motor.

Application

• Industrial - Motor Drive

Features

- FET can be driven (built-in pre-driver IC) by microcontroller output (logic system).
- Various protections (Overcurrent Protection, Over Temperature Protection, Low Voltage Protection, Over Voltage Protection) are incorporated.
- Intelligent DIAG Function that externally outputs each protection status, such as Overcurrent Protection, Over Temperature Protection.
- Protection functions can be reset by external inputs.

Series model

	STK984-091A-E	STK984-090A-E
VB max	40V	40V
ld max	20A	20A
IOC	91-170A	68-160A
ISD	48-90A	22-65A
TSD	135-145°C	126-136°C

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STK984-091A-E

Specifications

Absolute Maximum Ratings at Ta = 25°C, Tc = 25°C

Parameter	Symbol	Conditions	Ratings	Unit
Supply voltage	V+B1	+B1 to PG	0.01.40	
	V+B2	+B2 to SG	-0.3 to 40	V
Control input voltage	V _{IN} max	UT, VT, WT, UB, VB, WB to SG	-0.3 to 6	V
DIAG terminal voltage	VDIAG	DIAG1, DIAG2 to SG	-0.3 to 6	V
Drain current	ld max	DC	20	Α
		Pulse (Single-Shot within 10μs)	180	Α
Junction temperature	Tj max	Semiconductor device	150	°C
Storage temperature	Tstg		-40 to +125	°C

Recommended Operating Conditions at $-40^{\circ}\text{C} \le \text{Tc} \le 125^{\circ}\text{C}$

Parameter	Symbol	Test Conditions	min	typ	max	Unit	
Supply voltage	V+B1	+B1 to PG		8 13.5			.,
	V+B2	+B2 to SG	8		18	V	
Output current	lo	I _O ∞ ON duty, ON duty100% 120deg excitation method			20	А	
Operating substrate temperature	Тс	Thick film IC substrate temperature	-40		125	°C	
Drive PWM frequency	FO	ONDuty: 10 to 90%, 100%			20	kHz	

Thermal Resistance

Parameter	Symbol	Test Conditions	min	typ	max	Unit
Chip-case resistance	θјс	Junction -to- backside of the substrate		4.5		°C/M
		MOSFET/ch		4.5		°C/W

Electrical Characteristics at Ta = 25°C, V+B1 (V+B2) = 13.5V unless otherwise specified

Parameter	Symbol	٦	Test Conditions	min	typ	max	Unit
Current consumption (Control system)	lcc	V+B1=V+B2=16V			10	15	mA
Output saturation voltage	V _{DS} (sat)	I _O =20A	+B1 to U, V, W		0.3	0.5	.,
			U, V, W to PG		0.2	0.4	V
Current sensing resistor	Rs			2.91	3.00	3.09	mΩ
Time delay (ON)	td(on)	20A	U, V, W	0.9	1.8	2.8	
			U-, V-, W-	0.9	1.9	3.0	μS
Rise time	tr	20A	·		0.3		μS
Time delay (OFF)	td(off)	20A	U, V, W	1.3	2.9	4.5	
			U-, V-, W-	0.8	2.2	3.5	μS
Fall time	tf	20A			0.3		μS

Motor Control Input Terminal at $8V \le V + B1$ $(V + B2) \le 18V$, $-40^{\circ}C \le Ta \le 125^{\circ}C$

Parameter	Symbol	Test Conditions	min	typ	max	Unit
Input ON voltage	V _{IN} (on)	Output on UT, VT, WT, UB, VB, WB to SG	3.5			V
Input OFF voltage	V _{IN} (off)	Output off UT, VT, WT, UB, VB, WB to SG			1.5	V

Reset Input Terminal at $8V \le V + B1$ $(V + B2) \le 18V$, $-40^{\circ}C \le Ta \le 125^{\circ}C$

Parameter	Symbol	Test Conditions	min	typ	max	Unit
Reset high voltage	Vreset(Hi)	Output ON	3.5			V
Reset low voltage	Vreset(Lo)	Output OFF			1.5	V
Output delay time (ON)	treset(on)	From reset input terminal (RESET=Hi) to output ON		0.25		ms
Output delay time (OFF)	treset(off)	From reset input terminal (RESET=Lo) to output OFF		2		μS

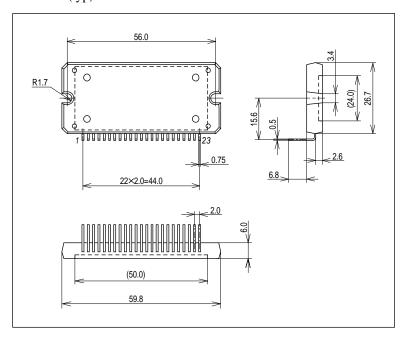
STK984-091A-E

Protective Function at $Ta = 25^{\circ}C$, V+B1 (V+B2) = 13.5V unless otherwise specified

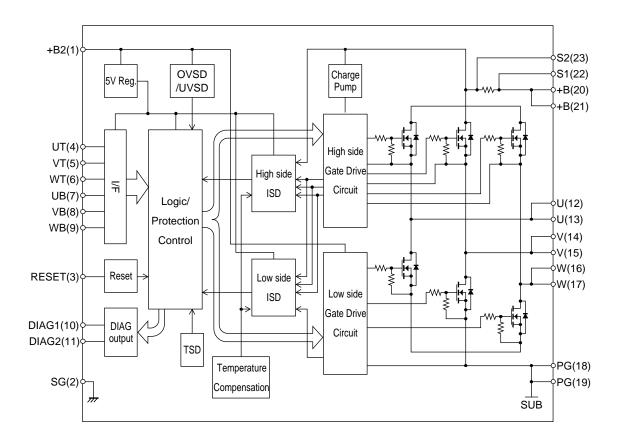
Parameter	Symbol	Test Conditions	min	typ	max	Unit
Low voltage protection threshold	Vuv		4.45	4.75	5.1	V
Low voltage protection hysteresis	Vuv(hy)		0.07	0.2	0.3	V
Low voltage shutdown output delay	Tuvoff			1.0		μs
Over current threshold	ISD	Automatic recovery	48	68	90	Α
Over current DIAG output delay time	Tocdgoff			4.3		μS
Over current shutdown interval	tint			1		ms
Over current shutdown output delay	Tocoff			4.3		μS
Ground fault short-circuit protection	IOC	Power-cycle	91	134	170	Α
Ground fault short-circuit detection DIAG output delay time	Tspdgoff			3.0		ms
Ground fault short-circuit shutdown output delay time	Tspoff			3.0		ms
Temperature protection shutdown	Tst	Thick film IC substrate temperature, automatic restoration	135	140	145	°C
Temperature protection recovery	Tst(hy)	Thick film IC substrate temperature	115	120	125	°C
Over temperature DIAG output delay time	Tthdgoff			3.4		ms
Over temperature shutdown output delay	Tthoff			3.4		μS
Over voltage threshold	Vov		24			V
Over voltage protection hysteresis width	Vov(hy)			0.5		V
Over voltage shutdown output delay	Tovoff			1.0		μS

Package Dimensions

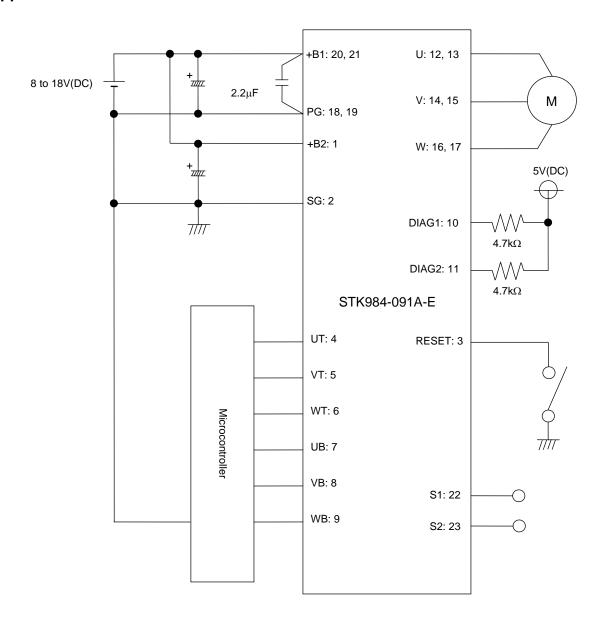
unit: mm (typ)



Internal Block Diagram



Application Circuit



NOTE

- 1. A voltage overshoot with vibration will be occurred during a switching operation due to floating inductance of the power source wiring connected between terminal +B1 and PG. In order that the voltage overshoot between +B1 and PG, +B1 and each –UBW, each UVW and PG will not exceed its rating, please minimize wiring inductance by shortening the wiring, also connect a snubber circuit close to between +B1 and PG terminals.
- 2. With the object of the overcurrent protection circuit fail-safe design, inserting a fuse in +B1 line is recommended.
- 3. There is a $100k\Omega$ (Typ) pull-down resister connected inside of the signal input terminal. However, in the case of mounting a resister externally to reduce noise due to wiring, please satisfy the input voltage threshold of this Hybrid-IC.
- 4. Terminal DIAG 1 and DIAG 2 are the open drain output configuration. Please pull up with $4.7k\Omega$ resister to 5V power supply.
- 5. There is a $100k\Omega$ (Typ) pull-up resister connected inside of the RESET terminal. It operates normally in the open-state. When the short-circuit protection operates and latches the output OFF, the latched output OFF can be released by making RESET terminal Low and re-opened.

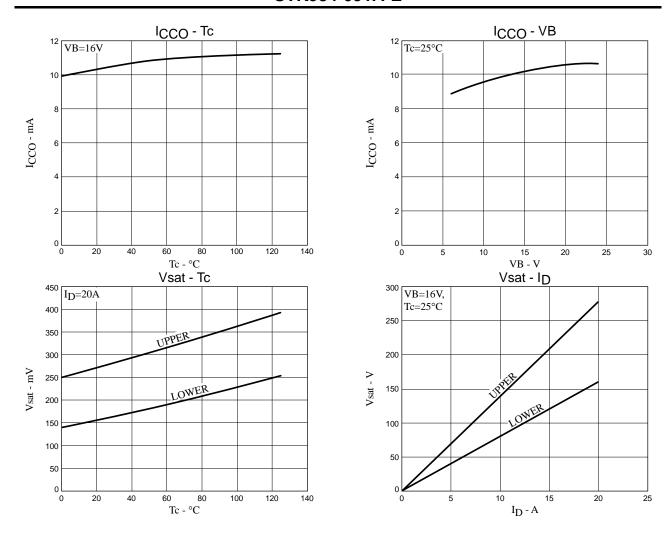
STK984-091A-E

Pin Function Description

Pin No.	Pin Name	Description	Pin*
1	+B2	Control System Power	S
2	SG	Control System GND	S
3	RESET	RESET Terminal Normal operating in RESET = H or Open-State The Gate Output will be Lo-state for both Hi/Lo sides with RESET = L (Output OFF) Output OFF Latch Release terminal of Short-circuit Protection	S
4	UT	Driving Signal Input Upper U-phase	S
5	VT	Driving Signal Input Upper V-phase	S
6	WT	Driving Signal Input Upper W-phase	S
7	UB	Driving Signal Input Lower U-phase	S
8	VB	Driving Signal Input Lower V-phase	S
9	WB	Driving Signal Input Lower W-phase	S
10	DIAG1	Fault Diagnosis Output 1 (Overcurrent) Normal Operation: Lo Abnormal Operation: Hi	S
11	DIAG2	Fault Diagnosis Output 2 (Over Temperature) Normal Operation: Lo Abnormal Operation: Hi	S
12	U	U-phase Output	Р
13	U	U-phase Output	Р
14	V	V-phase Output	Р
15	V	V-phase Output	Р
16	W	W-phase Output	Р
17	W	W-phase Output	Р
18	PG	Power System GND	Р
19	PG	Power System GND	Р
20	+B1	Power System Supply	Р
21	+B1	Power System Supply	Р
22	S1	Current Sense Resistor Sensing (+) terminal	S
23	S2	Current Sense Resistor Sensing (-) terminal	S

S: Signal terminal

P: Power terminal



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